

N-Channel 900V (D-S) Super Junction Power MOSFET

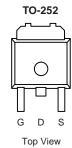
PRODUCT SUMMARY				
V _{DS} (V)	900			
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	2.7		
Q _g (Max.) (nC)	200			
Q _{gs} (nC)	24			
Q _{gd} (nC)	110			
Configuration	Single			

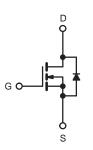
FEATURES

- · Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC









N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T_C = 25 °C, unless otherwise noted) **PARAMETER** SYMBOL LIMIT UNIT Drain-Source Voltage V_{DS} 900 ٧ Gate-Source Voltage ± 20 V_{GS} $T_C = 25 \, ^{\circ}C$ 2.0 V_{GS} at 10 V Continuous Drain Current I_D T_C = 100 °C Α 1.5 Pulsed Drain Currenta 8.0 I_{DM} W/°C Linear Derating Factor 1.5 470 Single Pulse Avalanche Energyb E_{AS} mJ Repetitive Avalanche Currenta 4.8 Α I_{AR} Repetitive Avalanche Energya 19 mJ E_{AR} T_C = 25 °C Maximum Power Dissipation 120 W P_D Peak Diode Recovery dV/dtc dV/dt 2.0 V/ns Operating Junction and Storage Temperature Range T_J, T_{stg} - 55 to + 150 °C Soldering Recommendations (Peak Temperature) for 10 s 300d 10 $lbf \cdot in \\$ Mounting Torque 6-32 or M3 screw 1.1 $N \cdot m$

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. V_{DD} = 50 V, starting T_J = 25 °C, L = 23 mH, R_g = 25 Ω , I_{AS} = 7.8 A (see fig. 12). c. I_{SD} \leq 7.8 A, dl/dt \leq 140 A/ μ s, V_{DD} \leq 600 V, T_J \leq 150 °C.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	40		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.65		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	= 0 V, I _D = 250 μA	900	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.98	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} :	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V		-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		= 800 V, V _{GS} = 0 V V, V _{GS} = 0 V, T _J = 125 °C	-	-	100 500	μA
Drain-Source On-State Resistance	R _{DS(on)}		I _D = 1.7 A ^b	_	2.7	-	Ω
Forward Transconductance	9 _{fs}		= 100 V, I _D = 1.7 A ^b	5.6	-	-	S
Dynamic		1 30			l		1
Input Capacitance	C _{iss}		V 0V		1800	-	
Output Capacitance	C _{oss}	1	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$	-	500	-	рF
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	290	-	
Total Gate Charge	Qg			-	-	200	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V}$ $I_{D} = 1.8 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 ^b	-	-	24	nC
Gate-Drain Charge	Q _{gd}			-	-	110	
Turn-On Delay Time	t _{d(on)}				19	-	- ns
Rise Time	t _r	$V_{DD} = 400 \text{ V}, I_{D} = 1.8 \text{ A},$ $R_{g} = 6.2 \Omega, R_{D} = 52 \Omega$ see fig. 10^{b}		-	38	-	
Turn-Off Delay Time	$t_{d(off)}$			-	120	-	
Fall Time	t _f			-	39	-	
Internal Drain Inductance	L_{D}	6 mm (0.25")	Between lead, 6 mm (0.25") from		5.0	-	الم
Internal Source Inductance	L _S	package and center of die contact		-	13	-	- nH
Drain-Source Body Diode Characteristic	s					•	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.0	^
Pulsed Diode Forward Current ^a	I _{SM}			-	-	21	A
Body Diode Voltage	V_{SD}	T _J = 25 °C	T _J = 25 °C, I _S = 1.8 A, V _{GS} = 0 V ^b		-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 1.8 A, dl/dt = 100 A/μs ^b		-	650	980	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	3.8	5.7	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

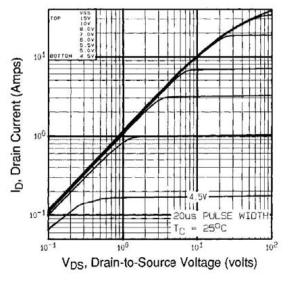


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

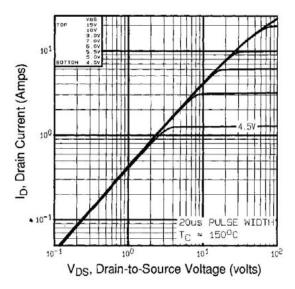


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

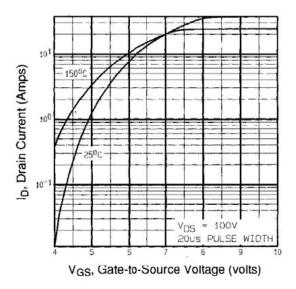


Fig. 3 - Typical Transfer Characteristics

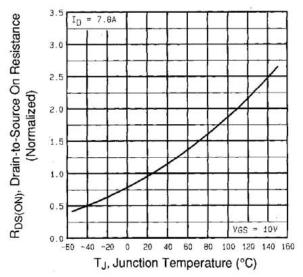


Fig. 4 - Normalized On-Resistance vs. Temperature



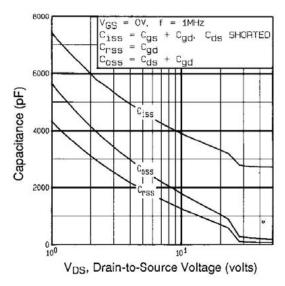


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

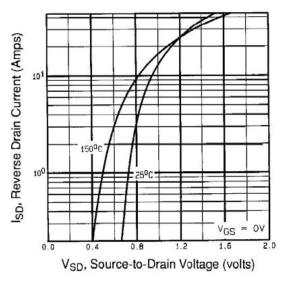


Fig. 7 - Typical Source-Drain Diode Forward Voltage

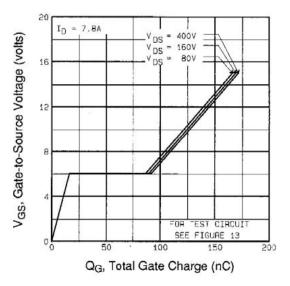


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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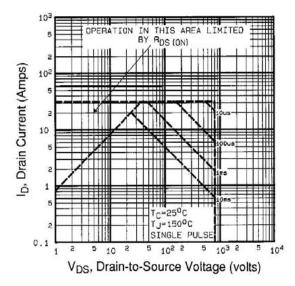


Fig. 8 - Maximum Safe Operating Area



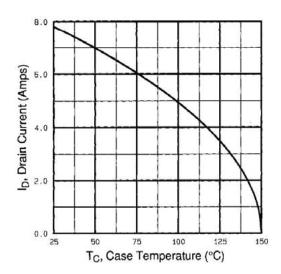


Fig. 9 - Maximum Drain Current vs. Case Temperature

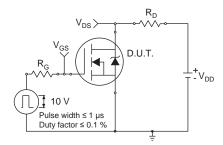


Fig. 10a - Switching Time Test Circuit

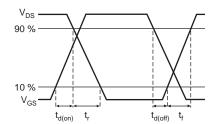


Fig. 10b - Switching Time Waveforms

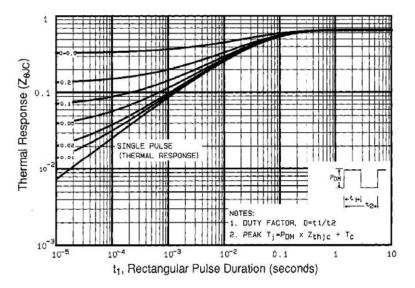


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



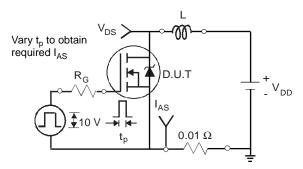


Fig. 12a - Unclamped Inductive Test Circuit

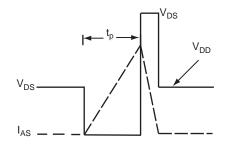


Fig. 12b - Unclamped Inductive Waveforms

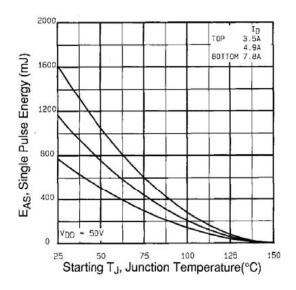


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

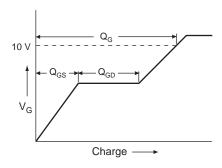


Fig. 13a - Basic Gate Charge Waveform

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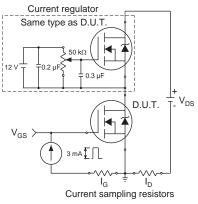
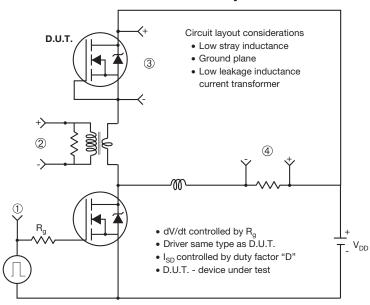


Fig. 13b - Gate Charge Test Circuit



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Peak Diode Recovery dV/dt Test Circuit



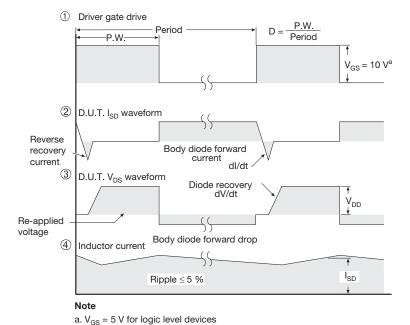
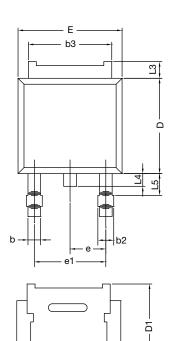
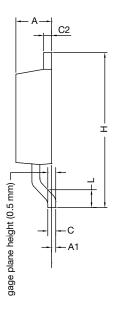


Fig. 14 - For N-Channel



TO-252AA CASE OUTLINE





	MILLIMETERS		INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	2.18	2.38	0.086	0.094	
A1	=	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	5.21	=	0.205	-	
Е	6.35	6.73	0.250	0.265	
E1	4.32	=	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28 BSC		0.090 BSC		
e1	4.56	4.56 BSC		0.180 BSC	
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	=	1.02	-	0.040	
L5	1.14	1.52	0.045	0.060	
ECN: X12-0247-Rev. M, 24-Dec-12 DWG: 5347					

Note

• Dimension L3 is for reference only.



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